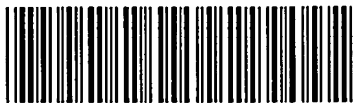


**Search Notes**

Application/Control No.

10/042,082

Examiner

Tse Chen

Applicant(s)/Patent under  
Reexamination

ABERNATHY ET AL.

Art Unit

2116

**SEARCHED**

Class	Subclass	Date	Examiner
713	300	7/13/06	TSE
713	600	7/13/06	TSE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
713	300	7/13/06	TSE
713	600	7/13/06	TSE

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR